

2N5556 2N5557 2N5558

n-channel JFETs designed for . . .



Performance Curves NRL
See Section 4

■ General Purpose Amplifiers

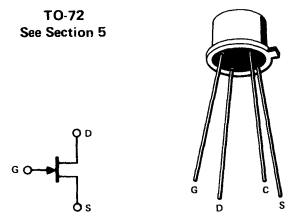
BENEFITS

- Low Noise
- Low Output Conductance

*ABSOLUTE MAXIMUM RATINGS (at 25°C)

Gate-Drain or Gate-Source Voltage (Note 1)	-30 V
Gate Current	10 mA
Total Device Dissipation (25°C Free Air Temperature)	300 mW
Power Derating (to +175°C)	2.0 mW/°C
Storage Temperature Range	-65 to +200°C
Operating Temperature Range	-65 to +175°C
Lead Temperature (1/16" from case for 10 seconds)	240°C

TO-72
See Section 5



*ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

Characteristic		2N5556		2N5557		2N5558		Unit	Test Conditions			
		Min	Max	Min	Max	Min	Max					
1 2 3 4 5 6 7 8 9 10 11 12 13	S T A T I C	IGSS	Gate Reverse Current	-0.1		-0.1		-0.1	nA	VGS = -15 V, VDS = 0 V	T = 150°C	
				-100		-100		-100				
		VGS(off)	Gate-Source Cutoff Voltage	-0.2	-4.0	-0.8	5.0	-1.5	-6.0	V		VDS = 15 V, ID = 1 nA
		BVGS	Gate-Source Breakdown Voltage	-30		-30		-30		IG = -10 μA, VDS = 0 V		
		IDSS	Saturation Drain Current (Note 2)	0.5	2.5	2.0	5.0	4.0	10.0	mA	VDS = 15 V, VGS = 0 V	
	D Y N A M I C	gfs	Common-Source Forward Transconductance	1500	6500	1500	6500	1500	6500	μmho	VDS = 15 V, VGS = 0 V	f = 1 kHz
		gos	Common-Source Output Conductance		20		20		20			
		Crss	Common-Source Reverse Transfer Capacitance		3		3		3	pF		f = 1 MHz
		Ciss	Common-Source Input Capacitance		6		6		6			f = 10 Hz
		en	Common-Source Equivalent Short Circuit Input Noise Voltage		35		35		35	nV/√Hz		f = 100 Hz
		NF	Noise Figure		1		1		1	dB	VDS = 15 V, VGS = 0 V, BW = 1.0 Hz	f = 10 Hz
					1		1		1			f = 100 Hz

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*JEDEC registered data
NOTES:

1. Geometry is symmetrical. Units may be operated with source and drain leads interchanged.
2. Pulse test duration ≤ 2 ms.

NRL